

Notice of References Cited		Application/Control No. 10/712,426	Applicant(s)/Patent Under Reexamination LEE, CHANG-HYUN	
		Examiner Andy Huynh	Art Unit 2818	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,188,976	02-1993	Kume et al.	438/258
	B	US-6,306,690	10-2001	Kaya et al.	438/136
	C	US-6,440,798	08-2002	Lai et al.	438/266
	D	US-6,759,706	07-2004	Kobayashi, Takashi	257/314
	E	US-6,781,193	08-2004	Lee et al.	257/326
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	2002-0094505	12-2002	Korea	Choi et al.	
*	O	2003-0001088	01-2003	Korea	Cho et al.	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.